Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,517	ISHIGURO ET AL.
Examiner	Art Unit
Tu X. Nguyen	2618

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	69	4/27/2007	TN
	522		
	523		
	506		
370	311		
	349		
	335		

INT	ERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	
		· ·	

SEAI (INCLUDING S	RCH NOT SEARCH S	ES STRATEGY	)
		DATE	EXMR
Search East		4/27/2007	TN
,			